# Chopper-Stabilized, Two-Wire Hall-Effect Switches 

## FEATURES AND BENEFITS

- AEC-Q100 automotive qualified
- High-speed, 4-phase chopper stabilization
- Low switchpoint drift throughout temperature range
- Low sensitivity to thermal and mechanical stresses
- On-chip protection
$\square$ Supply transient protection
$\square$ Reverse-battery protection
$\square$ On-board voltage regulator
$\square 3$ to 24 V operation
- Solid-state reliability
- Robust EMC and ESD performance
- Industry-leading ISO 7637-2 performance through use of proprietary, 40 V clamping structures
Continued on the next page...


## Packages



Approximate footprint

## DESCRIPTION

The A1150, A1152, A1153, A1155, A1156, A1157, and A1158 comprise a family of two-wire, unipolar, Hall-effect switches, which are factory-trimmed to optimize magnetic switchpoint accuracy. These devices are produced on the Allegro ${ }^{\mathrm{TM}}$ advanced BiCMOS wafer fabrication process, which implements a high-frequency, 4-phase, chopper-stabilization technique. This technique achieves magnetic stability over the full operating temperature range, and eliminates offsets inherent in devices with a single Hall element that are exposed to harsh application environments.

The A115x family has a number of automotive applications. These include sensing seat track position, seat belt buckle presence, hood/trunk latching, and shift selector position.

Two-wire unipolar switches are particularly advantageous in cost-sensitive applications because they require one less wire for operation versus the more traditional open-collector output switches. Additionally, the system designer inherently gains diagnostics because there is always output current flowing, which should be in either of two narrow ranges. Any current level not within these ranges indicates a fault condition.
All family members are offered in three package styles. The LH is a SOT-23W style, miniature, low profile package for surface-mount applications. The UA is a 3-pin, ultra-mini, single inline package (SIP) for through-hole mounting. The UB is a 2-pin, ultra-mini, single inline package (SIP) for through-hole mounting. All three packages are lead (Pb) free, with $100 \%$ matte-tin leadframe plating.


Functional Block Diagram

## Chopper-Stabilized, Two-Wire Hall-Effect Switches

## Features and Benefits (continued)

- Extended Operating Ambient temperature range, $-40^{\circ} \mathrm{C}$ to $150^{\circ} \mathrm{C}$
- UB package with integrated $0.1 \mu \mathrm{~F}$ bypass capacitor


## Selection Guide

| Part Number | Packing | Package | Output (Icc) in South Polarity Field | ```Supply Current at ICC(L) (mA)``` | Magnetic Operate Point, $B_{\text {OP }}$ (G) |
| :---: | :---: | :---: | :---: | :---: | :---: |
| A1150LLHLX-T | 13-in. reel, 10000 pieces/reel | 3-pin SOT23W surface mount |  |  | 50 to 110 |
| A1150LUA-T | Bulk, 500 pieces/bag | 3-pin SIP through hole | Low | 2 to |  |
| A1152LLHLX-T | 13-in. reel, 10000 pieces/reel | 3-pin SOT23W surface mount | Low | 5 to 6.9 |  |
| A1152LUA-T | Bulk, 500 pieces/bag | 3-pin SIP through hole |  |  |  |
| A1152LUBTN-T | 13-in. reel, 4000 pieces/reel | 2-pin SIP through hole |  |  |  |
| A1153LLHLX-T | 13-in. reel, 10000 pieces/reel | 3-pin SOT23W surface mount |  |  |  |
| A1153LUA-T | Bulk, 500 pieces/bag | 3-pin SIP through hole | High | 5 to 6.9 |  |
| A1153LUBTN-T | 13-in. reel, 4000 pieces/reel | 2-pin SIP through hole |  |  |  |
| A1155LLHLX-T | 13-in. reel, 10000 pieces/reel | 3-pin SOT23W surface mount |  |  | 20 to 60 |
| A1155LUA-T | Bulk, 500 pieces/bag | 3-pin SIP through hole | Low | 5 to 6.9 |  |
| A1155LUBTN-T | 13-in. reel, 4000 pieces/reel | 2-pin SIP through hole |  |  |  |
| A1156LLHLX-T | 13-in. reel, 10000 pieces/reel | 3-pin SOT23W surface mount | High | 5 to 6.9 |  |
| A1156LUA-T | Bulk, 500 pieces/bag | 3-pin SIP through hole |  |  |  |
| A1156LUBTN-T | 13-in. reel, 4000 pieces/reel | 2-pin SIP through hole |  |  |  |
| A1157LLHLX-T | 13-in. reel, 10000 pieces/reel | 3-pin SOT23W surface mount | Low | 2 to 5 | 20 to 80 |
| A1157LLHLT-T | 7-in. reel, 3000 pieces/reel | 3-pin SOT23W surface mount |  |  |  |
| A1157LUA-T | Bulk, 500 pieces/bag | 3-pin SIP through hole |  |  |  |
| A1158LLHLX-T | 13-in. reel, 10000 pieces/reel | 3-pin SOT23W surface mount | High |  |  |
| A1158LLHLT-T | 7-in. reel, 3000 pieces/reel | 3-pin SOT23W surface mount |  |  |  |
| A1158LUA-T | Bulk, 500 pieces/bag | 3-pin SIP through hole |  |  |  |

## SPECIFICATIONS

Absolute Maximum Ratings

| Characteristic | Symbol | Notes | Rating | Unit |
| :--- | :---: | :---: | :---: | :---: |
| Forward Supply Voltage | $\mathrm{V}_{\mathrm{CC}}$ |  | 28 | V |
| Reverse Supply Voltage | $\mathrm{V}_{\mathrm{RCC}}$ |  | -18 | V |
| Magnetic Flux Density | B |  | Unlimited | G |
| Operating Ambient Temperature | $\mathrm{T}_{\mathrm{A}}$ | Range L | -40 to 150 | ${ }^{\circ} \mathrm{C}$ |
| Maximum Junction Temperature | $\mathrm{T}_{\mathrm{J}}(\max )$ |  | 165 | ${ }^{\circ} \mathrm{C}$ |
| Storage Temperature | $\mathrm{T}_{\mathrm{stg}}$ |  | -65 to 170 | ${ }^{\circ} \mathrm{C}$ |

## Pin-Out Diagrams and Terminal List Table



LH and UA Terminal List Table

| Number | Name |  | Function |
| :---: | :---: | :---: | :---: |
|  | LH package | UA package |  |
| 1 | VCC | VCC | Input power supply |
| 2 | NC | GND | LH package: no connection, it is highly recommended that this pin be tied to GND <br> UA package: ground terminal |
| 3 | GND | GND | Ground terminal |



UB Terminal List Table

| Number | Name | Function |
| :---: | :---: | :--- |
| 1 | VCC | Input power supply |
| 2 | GND | Ground terminal |

UB Package

## Chopper-Stabilized, Two-Wire Hall-Effect Switches

ELECTRICAL CHARACTERISTICS: valid at $T_{A}=-40^{\circ} \mathrm{C}$ to $150^{\circ} \mathrm{C}, \mathrm{T}_{J}<\mathrm{T}_{J}(\max ), \mathrm{C}_{\mathrm{BYP}}=0.01 \mu \mathrm{~F}$, through operating supply voltage range, unless otherwise noted

| Characteristics | Symbol | Test Conditions |  |  | Min. | Typ. | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Supply Voltage ${ }^{1,2}$ | $\mathrm{V}_{\mathrm{Cc}}$ | Operating, $\mathrm{T}_{\mathrm{J}} \leq 165^{\circ} \mathrm{C}$ |  |  | 3.0 | - | 24 | V |
| Supply Current | $\mathrm{I}_{\mathrm{CC}(\mathrm{L})}$ | A1150, A1157 |  | $\mathrm{B}>\mathrm{B}_{\mathrm{OP}}$ | 2.0 | - | 5.0 | mA |
|  |  | A1158 |  | $\mathrm{B}<\mathrm{B}_{\mathrm{RP}}$ |  |  |  |  |
|  |  | A1152, A1155 |  | $\mathrm{B}>\mathrm{B}_{\mathrm{OP}}$ | 5 | - | 6.9 | mA |
|  |  | A1153, A1156 |  | $\mathrm{B}<\mathrm{B}_{\mathrm{RP}}$ |  |  |  |  |
|  | $\mathrm{I}_{\mathrm{CC}(\mathrm{H})}$ | A1150, A1152, A1155, A1157 |  | $\mathrm{B}<\mathrm{B}_{\mathrm{RP}}$ | 12 | - | 17 | mA |
|  |  | $\begin{aligned} & \text { A1153, A1156, } \\ & \text { A1158 } \end{aligned}$ |  | $\mathrm{B}>\mathrm{B}_{\mathrm{OP}}$ |  |  |  |  |
| Supply Zener Clamp Voltage | $\mathrm{V}_{\mathrm{Z} \text { (sup) }}$ | $\mathrm{I}_{\mathrm{CC}(\mathrm{L})}(\mathrm{max})+3 \mathrm{~mA}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ |  |  | 28 | - | - | V |
| Supply Zener Clamp Current | $I_{\text {(sup) }}$ | $\mathrm{V}_{\mathrm{Z} \text { (sup) }}=28 \mathrm{~V}$ |  |  | - | - | ${ }^{\mathrm{CC}(L)}(\mathrm{max})$ $+3 \mathrm{~mA}$ | mA |
| Reverse Supply Current | $\mathrm{I}_{\mathrm{RCC}}$ | $\mathrm{V}_{\mathrm{RCC}}=-18 \mathrm{~V}$ |  |  | - | - | -1.6 | mA |
| Output Slew Rate ${ }^{3}$ | di/dt | LH and UA | No bypass capacitor, capacitance of probe $\mathrm{C}_{\mathrm{S}}=20 \mathrm{pF}$ |  | - | 90 | - | $\mathrm{mA} / \mu \mathrm{s}$ |
|  |  | UB | Integrated bypass capacitor, capacitance of probe $\mathrm{C}_{\mathrm{S}}=20 \mathrm{pF}$ |  | - | 0.22 | - | $\mathrm{mA} / \mu \mathrm{s}$ |
| Chopping Frequency | $\mathrm{f}_{\mathrm{c}}$ |  |  |  | - | 700 | - | kHz |
| Power-Up Time ${ }^{4,5}$ | $\mathrm{t}_{\text {on }}$ | A115 A115 | $\begin{aligned} & \text { 11152, } \\ & \text { A1157 } \end{aligned}$ | $B>B_{O P}+10 \mathrm{G}$ | - | - | 25 | $\mu \mathrm{s}$ |
|  |  | A115 A115 | 1156, | $\mathrm{B}<\mathrm{B}_{\mathrm{RP}}-10 \mathrm{G}$ |  |  |  |  |
| Power-Up State ${ }^{2,4,6,7}$ | POS | $\mathrm{t}_{\text {on }}<\mathrm{t}_{\text {on }}(\mathrm{max}), \mathrm{V}_{\text {CC }}$ slew rate $>25 \mathrm{mV} / \mu \mathrm{s}$ |  |  | - | $\mathrm{I}_{\mathrm{CC}(\mathrm{H})}$ | - | - |

${ }^{1} V_{C C}$ represents the generated voltage between the VCC pin and the GND pin.
${ }^{2}$ The $\mathrm{V}_{\mathrm{cc}}$ slew rate must exceed $600 \mathrm{mV} / \mathrm{ms}$ from 0 to 3 V . A slower slew rate through this range can affect device performance.
${ }^{3}$ Measured without bypass capacitor between VCC and GND. Use of a bypass capacitor results in slower current change.
4 Power-Up Time is measured without and with bypass capacitor of $0.01 \mu \mathrm{~F}$. Adding a larger bypass capacitor would cause longer Power-Up Time.
${ }^{5}$ Guaranteed by characterization and design.
${ }^{6}$ Power-Up State as defined is true only with a $V_{C C}$ slew rate of $25 \mathrm{mV} / \mu \mathrm{s}$ or greater.
${ }^{7}$ For $t>t_{\text {on }}$ and $B_{R P}<B<B_{O P}$, Power-Up State is not defined.

MAGNETIC CHARACTERISTICS1: Valid at $\mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $150^{\circ} \mathrm{C}, \mathrm{T}_{\mathrm{J}}<\mathrm{T}_{\mathrm{J}}$ (max), unless otherwise noted

| Characteristics | Symbol |  | Min. | Typ. | Max. | Unit ${ }^{2}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Magnetic Operating Point | $\mathrm{B}_{\text {OP }}$ | A1150, A1152, A1153 | 50 | - | 110 | G |
|  |  | A1155, A1156 | 20 | - | 60 | G |
|  |  | A1157, A1158 | 20 | - | 80 | G |
| Magnetic Release Point | $\mathrm{B}_{\mathrm{RP}}$ | A1150, A1152, A1153 | 45 | - | 105 | G |
|  |  | A1155, A1156 | 10 | - | 55 | G |
|  |  | A1157, A1158 | 10 | - | 60 | G |
| Hysteresis | $\mathrm{B}_{\mathrm{HYS}}$ |  | 5 | - | 30 | G |

${ }^{1}$ Relative values of $B$ use the algebraic convention, where positive values indicate south magnetic polarity, and negative values indicate north magnetic polarity; therefore greater $B$ values indicate a stronger south polarity field (or a weaker north polarity field, if present).
21 G (gauss) $=0.1 \mathrm{mT}$ (millitesla).

THERMAL CHARACTERISTICS: may require derating at maximum conditions; see application information

| Characteristic | Symbol | Test Conditions* | Value | Unit |
| :---: | :---: | :---: | :---: | :---: |
| Package Thermal Resistance | $\mathrm{R}_{\text {өJA }}$ | Package LH, on 1-layer PCB with copper limited to solder pads | 228 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
|  |  | Package LH, on 2-layer PCB with 0.463 in. ${ }^{2}$ of copper area each side | 110 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
|  |  | Package UA, on 1-layer PCB with copper limited to solder pads | 165 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
|  |  | Package UB, on 1-layer PCB with copper limited to solder pads | 213 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |

*Additional thermal information available on the Allegro website


LH and UA Power Dissipation versus Ambient Temperature


UB Power Derating Curve


UB Power Dissipation versus Ambient Temperature


# Chopper-Stabilized, Two-Wire Hall-Effect Switches 

## CHARACTERISTIC PERFORMANCE

A1152/A1153/A1155/A1156
Average Supply Current (Low) versus Temperature



A1150/A1152/A1153/A1155/A1156/A1157/A1158
Average Supply Current (High) versus Temperature


A1152/A1153/A1155/A1156
Average Supply Current (Low) versus Supply Voltage


A1150/A1157/A1158
Average Supply Current (Low) versus Supply Voltage


A1150/A1152/A1153/A1155/A1156/A1157/A1158
Average Supply Current (High) versus Supply Voltage


A1150, A1152, A1153, A1155,
A1156, A1157, and A1158

## Chopper-Stabilized, Two-Wire Hall-Effect Switches

A1150/A1152/A1153
Average Operate Point versus Temperature


A1150/A1152/A1153
Average Release Point versus Temperature


A1150/A11A11, 5 P1 Average Switchpoint Hysteresis versus Temperature


A1155/A1156
Average Operate Point versus Temperature


A1155/A1156
Average Release Point versus Temperature


A1150/A1152/A1115ぼ//ATH1659A1156/A1157/A1158 Average Switchpoint Hysteresis versus Temperature


## Chopper-Stabilized, Two-Wire <br> Hall-Effect Switches

## FUNCTIONAL DESCRIPTION

The A1150, A1152, A1155, and A1157 output, $\mathrm{I}_{\mathrm{CC}}$, switches low after the magnetic field at the Hall sensor IC exceeds the operate point threshold, $\mathrm{B}_{\mathrm{OP}}$. When the magnetic field is reduced to below the release point threshold, $\mathrm{B}_{\mathrm{RP}}$, the device output goes high. This is shown in Figure 1, panel A.

In the case of the reverse output polarity, as in the A1153, A1156, and A1158, the device output switches high after the magnetic
field at the Hall sensor IC exceeds the operate point threshold, $\mathrm{B}_{\mathrm{OP}}$. When the magnetic field is reduced to below the release point threshold, $\mathrm{B}_{\mathrm{RP}}$, the device output goes low (panel B).

The difference between the magnetic operate and release points is called the hysteresis of the device, $\mathrm{B}_{\mathrm{HYS}}$. This built-in hysteresis allows clean switching of the output even in the presence of external mechanical vibration and electrical noise.

(A) Hysteresis curve for A1150, A1152, A1155, and A1157

(B) Hysteresis curve for A1153, A1156, and A1158

Figure 1: Alternative Switching Behaviors Available in the A115x Device Family.
On the horizontal axis, the $B+$ direction indicates increasing south polarity magnetic field strength, and the $B$-direction indicates decreasing south polarity field strength (including the case of increasing north polarity).

# Chopper-Stabilized, Two-Wire Hall-Effect Switches 



Figure 2: Typical Application Circuits

## Chopper Stabilization Technique

When using Hall-effect technology, a limiting factor for switchpoint accuracy is the small signal voltage developed across the Hall element. This voltage is disproportionally small relative to the offset that can be produced at the output of the Hall sensor IC. This makes it difficult to process the signal while maintaining an accurate, reliable output over the specified operating temperature and voltage ranges. Chopper stabilization is a unique approach used to minimize Hall offset on the chip. The Allegro technique, namely Dynamic Quadrature Offset Cancellation, removes key sources of the output drift induced by thermal and mechanical stresses. This offset reduction technique is based on a signal modulation-demodulation process. The undesired offset signal is separated from the magnetic field-induced signal in the frequency domain, through modulation. The subsequent demodulation acts as a modulation process for the offset, causing the magnetic field-induced signal to recover its original spectrum
at base band, while the DC offset becomes a high-frequency signal. The magnetic-sourced signal then can pass through a lowpass filter, while the modulated DC offset is suppressed. The chopper stabilization technique uses a 350 kHz high frequency clock. For demodulation process, a sample and hold technique is used, where the sampling is performed at twice the chopper frequency. This high-frequency operation allows a greater sampling rate, which results in higher accuracy and faster signal-processing capability. This approach desensitizes the chip to the effects of thermal and mechanical stresses, and produces devices that have extremely stable quiescent Hall output voltages and precise recoverability after temperature cycling. This technique is made possible through the use of a BiCMOS process, which allows the use of low-offset, low-noise amplifiers in combination with high-density logic integration and sample-and-hold circuits.


Figure 3: Chopper Stabilization Circuit (Dynamic Quadrature Offset Cancellation)

## Chopper-Stabilized, Two-Wire Hall-Effect Switches

## Power Derating

The device must be operated below the maximum junction temperature of the device, $\mathrm{T}_{\mathrm{J}}$ (max). Under certain combinations of peak conditions, reliable operation may require derating supplied power or improving the heat dissipation properties of the application. This section presents a procedure for correlating factors affecting operating $\mathrm{T}_{\mathrm{J}}$. (Thermal data is also available on the Allegro MicroSystems Web site.)

The Package Thermal Resistance, $\mathrm{R}_{\theta J A}$, is a figure of merit summarizing the ability of the application and the device to dissipate heat from the junction (die), through all paths to the ambient air. Its primary component is the Effective Thermal Conductivity, K , of the printed circuit board, including adjacent devices and traces. Radiation from the die through the device case, $\mathrm{R}_{\theta \mathrm{JC}}$, is relatively small component of $\mathrm{R}_{\theta \mathrm{JA}}$. Ambient air temperature, $\mathrm{T}_{\mathrm{A}}$, and air motion are significant external factors, damped by overmolding.

The effect of varying power levels (Power Dissipation, $\mathrm{P}_{\mathrm{D}}$ ), can be estimated. The following formulas represent the fundamental relationships used to estimate $T_{J}$, at $\mathrm{P}_{\mathrm{D}}$.

$$
\begin{gather*}
P_{D}=V_{I N} \times I_{I N}  \tag{1}\\
\Delta T=P_{D} \times R_{\theta J A}  \tag{2}\\
T_{J}=T_{A}+\Delta T \tag{3}
\end{gather*}
$$

For example, given common conditions such as: $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$, $\mathrm{V}_{\mathrm{CC}}=12 \mathrm{~V}, \mathrm{I}_{\mathrm{CC}}=4 \mathrm{~mA}$, and $\mathrm{R}_{\theta \mathrm{JA}}=140^{\circ} \mathrm{C} / \mathrm{W}$, then:

$$
\begin{gathered}
P_{D}=V_{C C} \times I_{C C}=12 \mathrm{~V} \times 4 \mathrm{~mA}=48 \mathrm{~mW} \\
\Delta T=P_{D} \times R_{\theta J A}=48 \mathrm{~mW} \times 140^{\circ} \mathrm{C} / \mathrm{W}=7^{\circ} \mathrm{C}
\end{gathered}
$$

$$
T_{J}=T_{A}+\Delta T=25^{\circ} \mathrm{C}+7^{\circ} \mathrm{C}=32^{\circ} \mathrm{C}
$$

A worst-case estimate, $\mathrm{P}_{\mathrm{D}}(\max )$, represents the maximum allowable power level $\left(\mathrm{V}_{\mathrm{CC}}(\max ), \mathrm{I}_{\mathrm{CC}}(\max )\right)$, without exceeding $\mathrm{T}_{\mathrm{J}}(\max )$, at a selected $\mathrm{R}_{\theta \mathrm{JA}}$ and $\mathrm{T}_{\mathrm{A}}$.
Example: Reliability for $\mathrm{V}_{\mathrm{CC}}$ at $\mathrm{T}_{\mathrm{A}}=150^{\circ} \mathrm{C}$, package UA , using a low-K PCB.

Observe the worst-case ratings for the device, specifically:
$\mathrm{R}_{\theta \mathrm{JA}}=165^{\circ} \mathrm{C} / \mathrm{W}, \mathrm{T}_{\mathrm{J}}(\max )=165^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{CC}}(\max )=24 \mathrm{~V}$, and $\mathrm{I}_{\mathrm{CC}}(\max )=17 \mathrm{~mA}$.

Calculate the maximum allowable power level, $\mathrm{P}_{\mathrm{D}}(\max )$. First, invert equation 3 :

$$
\Delta T_{\max }=T_{J}(\max )-T_{A}=165^{\circ} \mathrm{C}-150^{\circ} \mathrm{C}=15^{\circ} \mathrm{C}
$$

This provides the allowable increase to $\mathrm{T}_{\mathrm{J}}$ resulting from internal power dissipation. Then, invert equation 2 :

$$
P_{D}(\max )=\Delta T_{\max } \div R_{\theta J A}=15^{\circ} \mathrm{C} \div 165^{\circ} \mathrm{C} / \mathrm{W}=91 \mathrm{~mW}
$$

Finally, invert equation 1 with respect to voltage:

$$
V_{C C(e s t)}=P_{D}(\max ) \div I_{C C}(\max )=91 m W \div 17 m A=5 \mathrm{~V}
$$

The result indicates that, at $\mathrm{T}_{\mathrm{A}}$, the application and device can dissipate adequate amounts of heat at voltages $\leq \mathrm{V}_{\mathrm{CC}(\text { est) }}$.

Compare $\mathrm{V}_{\mathrm{CC}(\text { est })}$ to $\mathrm{V}_{\mathrm{CC}}(\max )$. If $\mathrm{V}_{\mathrm{CC}(\mathrm{est})} \leq \mathrm{V}_{\mathrm{CC}}(\max )$, then reliable operation between $\mathrm{V}_{\mathrm{CC}(\text { est })}$ and $\mathrm{V}_{\mathrm{CC}}(\max )$ requires enhanced $R_{\theta J A}$. If $V_{C C(e s t)} \geq V_{C C}(\max )$, then operation between $V_{C C(e s t)}$ and $\mathrm{V}_{\mathrm{CC}}(\max )$ is reliable under these conditions.

## Chopper-Stabilized, Two-Wire Hall-Effect Switches

## PACKAGE OUTLINE DRAWINGS

## For Reference Only - Not for Tooling Use <br> (Reference DWG-2840)

Dimensions in millimeters - NOT TO SCALE
Dimensions exclusive of mold flash, gate burrs, and dambar protrusions
Exact case and lead configuration at supplier discretion within limits shown

© Active Area Depth, 0.28 mm
B Reference land pattern layout; all pads a minimum of 0.20 mm from all adjacent pads; adjust as necessary to meet application process requirements and PCB layout tolerances

C Branding scale and appearance at supplier discretion
$\triangle$ Hall elements, not to scale
Figure 4: Package LH, 3-Pin SOT23W

## Chopper-Stabilized, Two-Wire Hall-Effect Switches

For Reference Only - Not for Tooling Use

Dimensions exclusive of mold flash, gate burrs, and dambar protrusions
Exact case and lead configuration at supplier discretion within limits shown


Figure 5: Package UA, 3-Pin SIP

## Chopper-Stabilized, Two-Wire <br> Hall-Effect Switches



Figure 6: Package UB, 2-Pin SIP

# Chopper-Stabilized, Two-Wire <br> Hall-Effect Switches 

## Revision History

| Revision | Revision Date | Description of Revision |
| :---: | :---: | :--- |
| 7 | May 22, 2014 | Added UB Package |
| 8 | October 2, 2014 | Revised UB packge drawing and reformatted document. |
| 9 | March 2, 2015 | Updated branding info on package drawing |
| 10 | September 21, 2015 | Corrected LH package Active Area Depth value; added AEC-Q100 qualification under Features and <br> Benefits |

Copyright ©2016, Allegro MicroSystems, LLC
Allegro MicroSystems, LLC reserves the right to make, from time to time, such departures from the detail specifications as may be required to permit improvements in the performance, reliability, or manufacturability of its products. Before placing an order, the user is cautioned to verify that the information being relied upon is current.
Allegro's products are not to be used in any devices or systems, including but not limited to life support devices or systems, in which a failure of Allegro's product can reasonably be expected to cause bodily harm.
The information included herein is believed to be accurate and reliable. However, Allegro MicroSystems, LLC assumes no responsibility for its use; nor for any infringement of patents or other rights of third parties which may result from its use.

For the latest version of this document, visit our website:
www.allegromicro.com

## X-ON Electronics

Largest Supplier of Electrical and Electronic Components
Click to view similar products for Board Mount Hall Effect/Magnetic Sensors category:
Click to view products by Allegro manufacturer:
Other Similar products are found below :
HGPRDT005A AH277AZ4-AG1 AV-10379 AV-10448 SS41C AH1894-Z-7 TLE4917 50017859-003 TY-13101 TLE4976L SS85CA BU52002GUL-E2 BU52003GUL-E2 AH277AZ4-BG1 TLE49614MXTSA1 AH211Z4-AG1 AH3360-FT4-7 TLE4941-1 SS460S100SAMPLE 50065820-03 AH374-P-A AH1806-P-A TLE49595UFXHALA1 SS460P-T2 AH1913-W-7 AH3373-P-B TLE9852QXXUMA1 TLE5046ICAKLRHALA1 AH1903-FA-EVM AH49FNTR-EVM AH8502-FDC-EVM AH3774-P-EVM TLE4998S3XALA1 TLE5011FUMA1 TLE5027CE6747HAMA1 TLE5109A16E1210XUMA1 TLI4966GHTSA1 TLI4906KHTSA1 MA710GQ-P S-57K1NBL2A-M3T2U S-57P1NBL9S-M3T4U S-576ZNL2B-L3T2U S-576ZNL2B-A6T8U S-57P1NBL0S-M3T4U S-57A1NSL1A-M3T2U S-57K1RBL1A-M3T2U S-57P1NBH9S-M3T4U S-57P1NBH0S-M3T4U S-57A1NSH1A-M3T2U S-57A1NSH2AM3T2U

